

RoHS COMPLIANT

# HYG046N04LQ1C2-VB Datasheet

## N-Channel 40 V (D-S) MOSFET

PRODUCT SUMMARY					
V <sub>DS</sub> (V)	R <sub>DS(on)</sub> (Ω)	I <sub>D</sub> (A) <sup>a, e</sup>	Q <sub>g</sub> (Typ.)		
40	0.0050 at V <sub>GS</sub> = 10 V	70	67 nC		
40	0.0060 at V <sub>GS</sub> = 4.5 V	65	07 110		

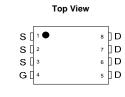
#### **FEATURES**

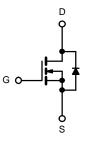
- Trench Power MOSFET ٠
- 100 % R<sub>g</sub> and UIS Tested ٠

#### **APPLICATIONS**

- Notebook PC Core
- VRM/POL ٠







N-Channel MOSFET

Parameter	Symbol	Limit	Unit	
Drain-Source Voltage	V <sub>DS</sub>	40	V	
Gate-Source Voltage	V <sub>GS</sub>	± 20	V	
	T <sub>C</sub> = 25 °C		70 <sup>a, e</sup>	
Continuous Drain Current (T <sub>J</sub> = 175 °C)	T <sub>C</sub> = 70 °C		60 <sup>e</sup>	
Continuous Drain Current (1) = 175 C)	T <sub>A</sub> = 25 °C	I I <sub>D</sub>	19 <sup>b, c</sup>	A
	T <sub>A</sub> = 70 °C	1	18.6 <sup>b, c</sup>	
Pulsed Drain Current	I <sub>DM</sub>	120		
Avalanche Current Pulse	L = 0.1 mH	I <sub>AS</sub>	21	
Single Pulse Avalanche Energy		E <sub>AS</sub>	47.2	mJ
Continuous Source-Drain Diode Current	T <sub>C</sub> = 25 °C	I <sub>S</sub>	70 <sup>a, e</sup>	A
Communus Source-Drain Diode Current	T <sub>A</sub> = 25 °C	'S	2.36 <sup>b, c</sup>	
	T <sub>C</sub> = 25 °C		100 <sup>a</sup>	
Maximum Power Dissipation	T <sub>C</sub> = 70 °C	P <sub>D</sub>	55	w
Maximum Power Dissipation	T <sub>A</sub> = 25 °C		6.15 <sup>b, c</sup>	V
	T <sub>A</sub> = 70 °C	] [	3.07 <sup>b, c</sup>	
Operating Junction and Storage Temperature R	T <sub>J</sub> , T <sub>stg</sub>	- 55 to 175	°C	

THERMAL RESISTANCE RATINGS						
Parameter		Symbol	Typical	Maximum	Unit	
Maximum Junction-to-Ambient <sup>b, d</sup>	ction-to-Ambient <sup>b, d</sup> $t \le 10 \text{ s}$		47	56	°C/W	
Maximum Junction-to-Case	Steady State	R <sub>thJC</sub>	0.8	1.1	0/10	

Notes:

a. Based on  $T_C = 25 \text{ °C}$ . b. Surface mounted on 1" x 1" FR4 board.

c. t = 10 s.

d. Maximum under steady state conditions is 90 °C/W.

e. Calculated based on maximum junction temperature. Package limitation current is 80 A.

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Parameter	Symbol	Test Conditions	Min .	Тур.	Max.	Unit	
Static			•			•	
Drain-Source Breakdown Voltage	V <sub>DS</sub>	$V_{GS} = 0 V, I_D = 250 \mu A$	40			V	
V <sub>DS</sub> Temperature Coefficient	$\Delta V_{DS}/T_{J}$			35		m\//°C	
V <sub>GS(th)</sub> Temperature Coefficient	$\Delta V_{GS(th)}/T_J$	$I_D = 250 \mu\text{A}$		- 5.5		mV/°0	
Gate-Source Threshold Voltage	V <sub>GS(th)</sub>	$V_{DS} = V_{GS}, I_{D} = 250 \ \mu A$	1.2		2.5	V	
Gate-Source Leakage	I <sub>GSS</sub>	$V_{DS} = 0 V, V_{GS} = \pm 20 V$			± 100	nA	
Zana Cata Maltana Duain Current		$V_{DS} = 40 \text{ V}, \text{ V}_{GS} = 0 \text{ V}$			1	μA	
Zero Gate Voltage Drain Current	IDSS	$V_{DS} = 40 \text{ V}, \text{ V}_{GS} = 0 \text{ V}, \text{ T}_{J} = 55 ^{\circ}\text{C}$			10		
On-State Drain Current <sup>a</sup>	I <sub>D(on)</sub>	$V_{DS} \ge 5$ V, $V_{GS}$ = 10 V	70			Α	
		V <sub>GS</sub> = 10 V, I <sub>D</sub> = 32 A		0.005		Ω	
Drain-Source On-State Resistance <sup>a</sup>	R <sub>DS(on)</sub>	$V_{GS} = 4.5 \text{ V}, \text{ I}_{D} = 29 \text{ A}$		0.006			
Forward Transconductance <sup>a</sup>	9 <sub>fs</sub>	V <sub>DS</sub> = 15 V, I <sub>D</sub> = 32 A		110		S	
Dynamic <sup>b</sup>						•	
Input Capacitance	C <sub>iss</sub>			1195		pF	
Output Capacitance	C <sub>oss</sub>	$V_{DS}$ = 12.5 V, $V_{GS}$ = 0 V, f = 1 MHz		975			
Reverse Transfer Capacitance	C <sub>rss</sub>			670			
Tatal Cata Charge	Qg	$V_{DS} = 15 \text{ V}, \text{ V}_{GS} = 10 \text{ V}, \text{ I}_{D} = 32 \text{ A}$		67		nC	
Total Gate Charge				57.3			
Gate-Source Charge	Q <sub>gs</sub>	$V_{DS}$ = 15 V, $V_{GS}$ = 4.5 V, $I_D$ = 29 A		31			
Gate-Drain Charge	Q <sub>gd</sub>			25			
Gate Resistance	Rg	f = 1 MHz		1.4	2.1	Ω	
Turn-On Delay Time	t <sub>d(on)</sub>			18	27		
Rise Time	t <sub>r</sub>	$V_{\text{DD}}$ = 15 V, $\text{R}_{\text{L}}$ = 0.555 $\Omega$		11	17		
Turn-Off Delay Time	t <sub>d(off)</sub>	$I_{D}\cong$ 27 A, $V_{GEN}$ = 10 V, $R_{g}$ = 1 $\Omega$		70	105	- ns	
Fall Time	t <sub>f</sub>			10	15		
Turn-On Delay Time	t <sub>d(on)</sub>			55	83		
Rise Time	t <sub>r</sub>	$V_{DD}$ = 15 V, $R_L$ = 0.625 $\Omega$		180	270		
Turn-Off Delay Time	t <sub>d(off)</sub>	$I_D \cong$ 24 A, $V_{GEN}$ = 4.5 V, $R_g$ = 1 $\Omega$		55	83		
Fall Time	t <sub>f</sub>			12	18		
Drain-Source Body Diode Characteristic	cs						
Continuous Source-Drain Diode Current	۱ <sub>S</sub>	T <sub>C</sub> = 25 °C			70	٨	
Pulse Diode Forward Current <sup>a</sup>	I <sub>SM</sub>				100	A	
Body Diode Voltage	V <sub>SD</sub>	I <sub>S</sub> = 22 A		0.8	1.2	V	
Body Diode Reverse Recovery Time	t <sub>rr</sub>		T	52	78	ns	
Body Diode Reverse Recovery Charge	Q <sub>rr</sub>	L = 20.4 di/dt = 100.4/we T = 25.00		70.2	105	nC	
Reverse Recovery Fall Time	ta	I <sub>F</sub> = 20 A, di/dt = 100 A/μs, T <sub>J</sub> = 25 °C		27			
Reverse Recovery Rise Time	t <sub>b</sub>			25		ns	

Notes:

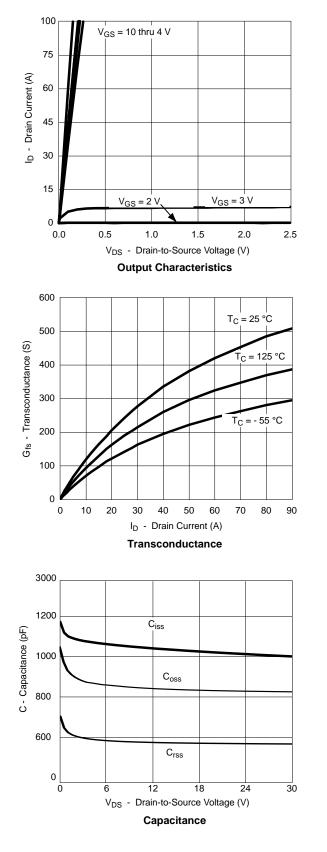
a. Pulse test; pulse width  $\leq$  300  $\mu s,$  duty cycle  $\leq$  2 %.

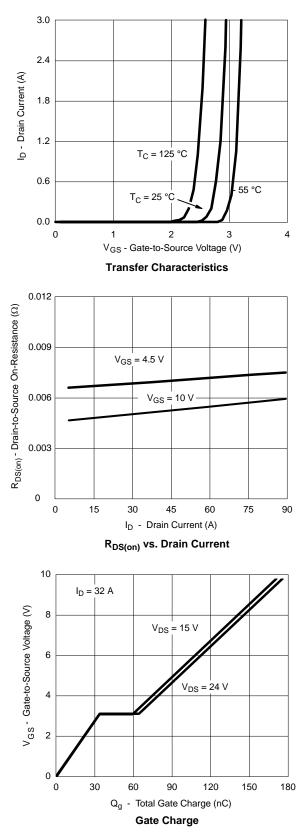
b. Guaranteed by design, not subject to production testing.

Stresses beyond those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated in the operational sections of the specifications is not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.



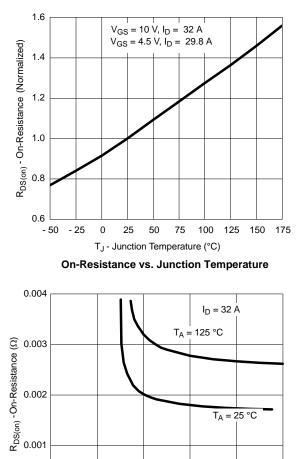
#### TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)

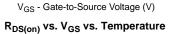






#### TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)





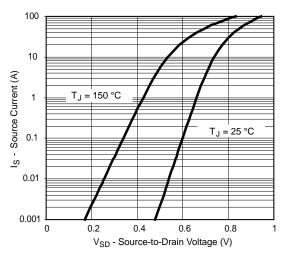
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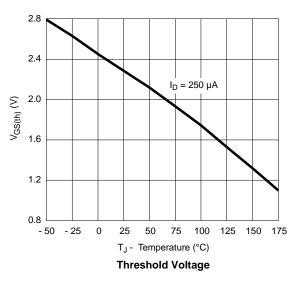
T<sub>A</sub> = 25 °C

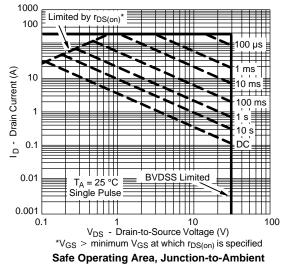
8

10



Forward Diode Voltage vs. Temperature



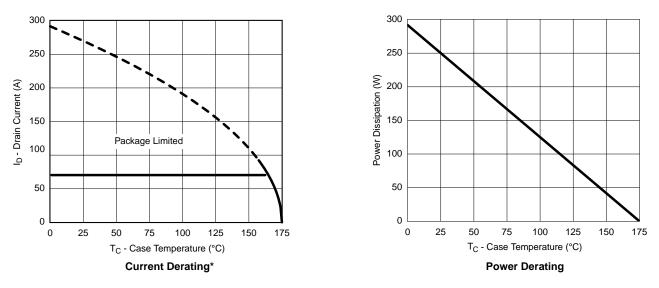


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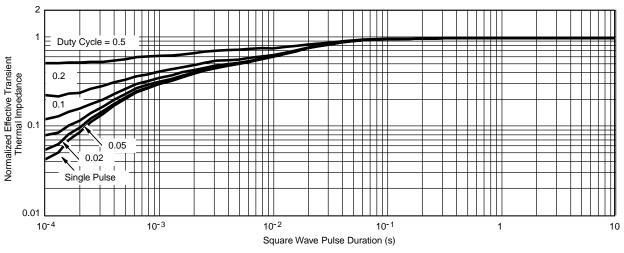
2





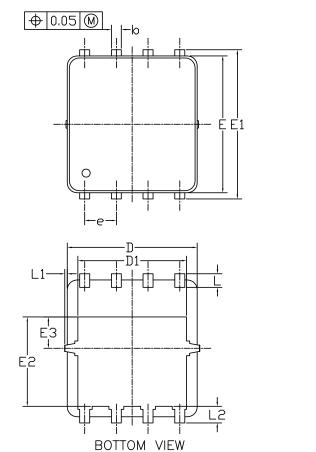
#### TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)

\* The power dissipation  $P_D$  is based on  $T_{J(max)}$  = 175 °C, using junction-to-case thermal resistance, and is more useful in settling the upper dissipation limit for cases where additional heatsinking is used. It is used to determine the current rating, when this rating falls below the package limit.

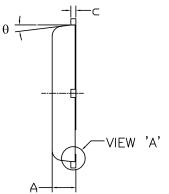


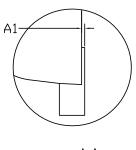
Normalized Thermal Transient Impedance, Junction-to-Case





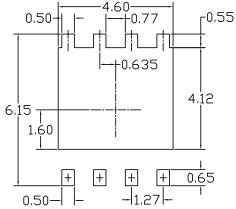
DFN5x6\_8L\_EP1\_P PACKAGE OUTLIN





<u>VIEW 'A'</u> (SCALE 5:1)

**RECOMMENDED LAND PATTERN** 



SYMBOLS	DIMENSIONS IN MILLIMETERS			DIMENSIONS IN INCHES		
STNBOLS	MIN	NOM	MAX	MIN	NOM	MAX
Α	0.85	0.95	1.00	0.033	0.037	0.039
A1	0.00		0.05	0.000		0.002
b	0.30	0.40	0.50	0.012	0.016	0.020
с	0.15	0.20	0.25	0.006	0.008	0.010
D	5.10	5.20	5.30	0.201	0.205	0.209
D1	4.25	4.35	4.45	0.167	0.171	0.175
Е	5.45	5.55	5.65	0.215	0.219	0.222
E1	5.95	6.05	6.15	0.234	0.238	0.242
E2	3.525	3.625	3.725	0.139	0.143	0.147
E3	1.175	1.275	1.375	0.046	0.050	0.054
e	1.27 BSC			0.050 BSC		
L	0.45	0.55	0.65	0.018	0.022	0.026
L1	0		0.15	0		0.006
L2	0.68 REF			0.027 REF		
θ	0°		10°	0°		10°

UNIT: mm

NOTE 1. PACKAGE BODY SIZES EXCLUDE MOLD FLASH AND GATE BURRS. MOLD FLASH AT THE NON-LEAD SIDES SHOULD BE LESS THAN 6 MILS EACH. 2. CONTROLLING DIMENSION IS MILLIMETER.

CONVERTED INCH DIMENSIONS ARE NOT NECESSARILY EXACT.



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